

6.5A, 30V, 0.030 Ohm, N-Channel, Logic Level UltraFET Power MOSFET



This N-Channel power MOSFET is manufactured using the innovative UltraFET™ process. This advanced process technology achieves the

lowest possible on-resistance per silicon area, resulting in outstanding performance. This device is capable of withstanding high energy in the avalanche mode and the diode exhibits very low reverse recovery time and stored charge. It was designed for use in applications where power efficiency is important, such as switching regulators, switching converters, motor drivers, relay drivers, low-voltage bus switches, and power management in portable and battery-operated products.

Formerly developmental type TA76113.

Ordering Information

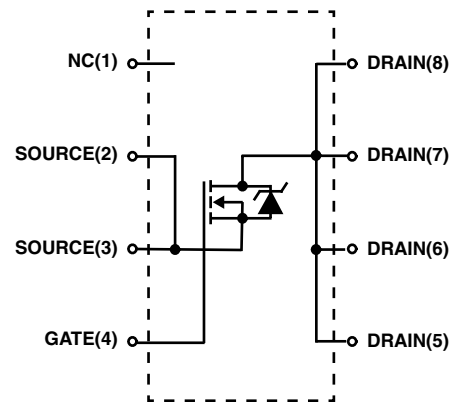
PART NUMBER	PACKAGE	BRAND
HUF76113SK8	MS-012AA	76113SK8

NOTE: When ordering, use the entire part number. Add the suffix T to obtain the variant in tape and reel, e.g., HUF76113SK8T.

Features

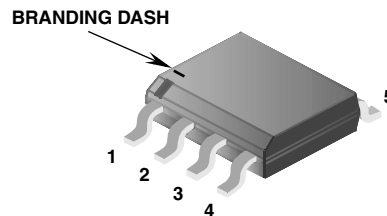
- Logic Level Gate Drive
- 6.5A, 30V
- Ultra Low On-Resistance, $r_{DS(ON)} = 0.030\Omega$
- Temperature Compensating PSPICE® Model
- Temperature Compensating SABER™ Model
- Thermal Impedance SPICE Model
- Thermal Impedance SABER Model
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- Related Literature
 - TB334, "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol



Packaging

JEDEC MS-012AA



HUF76113SK8

Absolute Maximum Ratings $T_A = 25^\circ\text{C}$, Unless Otherwise Specified

	HUF76113SK8	UNITS
Drain to Source Voltage (Note 1)	V_{DSS}	30 V
Drain to Gate Voltage ($R_{GS} = 20\text{k}\Omega$) (Note 1)	V_{DGR}	30 V
Gate to Source Voltage	V_{GS}	± 16 V
Drain Current		
Continuous ($T_A = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$) (Figure 2) (Note 2)	I_D	6.5 A
Continuous ($T_A = 100^\circ\text{C}$, $V_{GS} = 5\text{V}$) (Note 3)	I_D	2.0 A
Continuous ($T_A = 100^\circ\text{C}$, $V_{GS} = 4.5\text{V}$) (Note 3)	I_D	2.0 A
Pulsed Drain Current	I_{DM}	Figure 4
Pulsed Avalanche Rating	E_{ASB}	Figure 6
Power Dissipation (Note 2)		
Derate Above 25°C	P_D	2.5 W
		20 $\text{mW}/^\circ\text{C}$
Operating and Storage Temperature	T_J, T_{STG}	-55 to 150 $^\circ\text{C}$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	T_L	300 $^\circ\text{C}$
Package Body for 10s, See Techbrief 334	T_{pkg}	260 $^\circ\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- $T_J = 25^\circ\text{C}$ to 125°C .
- $50^\circ\text{C}/\text{W}$ measured using FR-4 board with 0.76 in^2 footprint at 10 seconds.
- $177^\circ\text{C}/\text{W}$ measured using FR-4 board with 0.0115 in^2 footprint at 1000 seconds.

Electrical Specifications $T_A = 25^\circ\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
OFF STATE SPECIFICATIONS						
Drain to Source Breakdown Voltage	BV_{DSS}	$I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$ (Figure 12)	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$	-	-	1	μA
		$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $T_A = 150^\circ\text{C}$	-	-	250	μA
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 16\text{V}$	-	-	± 100	nA
ON STATE SPECIFICATIONS						
Gate to Source Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}$, $I_D = 250\mu\text{A}$ (Figure 11)	1	-	3	V
Drain to Source On Resistance	$r_{DS(ON)}$	$I_D = 6.5\text{A}$, $V_{GS} = 10\text{V}$ (Figures 9, 10)	-	0.025	0.030	Ω
		$I_D = 2.0\text{A}$, $V_{GS} = 5\text{V}$ (Figure 9)	-	0.031	0.038	Ω
		$I_D = 2.0\text{A}$, $V_{GS} = 4.5\text{V}$ (Figure 9)	-	0.033	0.041	Ω
THERMAL SPECIFICATIONS						
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Pad Area = 0.76 in^2 (Note 2)	-	-	50	$^\circ\text{C}/\text{W}$
		Pad Area = 0.054 in^2 (See TB337)	-	-	143	$^\circ\text{C}/\text{W}$
		Pad Area = 0.0115 in^2 (See TB337)	-	-	177	$^\circ\text{C}/\text{W}$
SWITCHING SPECIFICATIONS ($V_{GS} = 4.5\text{V}$)						
Turn-On Time	t_{ON}	$V_{DD} = 15\text{V}$, $I_D \cong 2.0\text{A}$, $R_L = 7.5\Omega$, $V_{GS} = 4.5\text{V}$, $R_{GS} = 15\Omega$ (Figure 15)	-	-	100	ns
Turn-On Delay Time	$t_{d(ON)}$		-	16	-	ns
Rise Time	t_r		-	50	-	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	28	-	ns
Fall Time	t_f		-	34	-	ns
Turn-Off Time	t_{OFF}		-	-	91	ns

HUF76113SK8

Electrical Specifications $T_A = 25^\circ\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
SWITCHING SPECIFICATIONS ($V_{GS} = 10\text{V}$)							
Turn-On Time	t_{ON}	$V_{DD} = 15\text{V}$, $I_D \cong 6.5\text{A}$, $R_L = 2.31\Omega$, $V_{GS} = 10\text{V}$, $R_{GS} = 16\Omega$ (Figure 16)	-	-	59	ns	
Turn-On Delay Time	$t_{d(ON)}$		-	6.5	-	ns	
Rise Time	t_r		-	33	-	ns	
Turn-Off Delay Time	$t_{d(OFF)}$		-	45	-	ns	
Fall Time	t_f		-	40	-	ns	
Turn-Off Time	t_{OFF}		-	-	126	ns	
GATE CHARGE SPECIFICATIONS							
Total Gate Charge	$Q_{g(TOT)}$	$V_{GS} = 0\text{V to } 10\text{V}$	$V_{DD} = 15\text{V}$, $I_D \cong 2.0\text{A}$, $R_L = 7.5\Omega$ $I_{g(REF)} = 1.0\text{mA}$ (Figures 14)	-	17.5	21	nC
Gate Charge at 5V	$Q_{g(5)}$	$V_{GS} = 0\text{V to } 5\text{V}$		-	10	12	nC
Threshold Gate Charge	$Q_{g(TH)}$	$V_{GS} = 0\text{V to } 1\text{V}$		-	0.65	0.78	nC
Gate to Source Gate Charge	Q_{gs}			-	1.10	-	nC
Gate to Drain "Miller" Charge	Q_{gd}			-	5.40	-	nC
CAPACITANCE SPECIFICATIONS							
Input Capacitance	C_{ISS}	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$ (Figure 13)	-	585	-	pF	
Output Capacitance	C_{OSS}		-	327	-	pF	
Reverse Transfer Capacitance	C_{RSS}		-	73	-	pF	

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V_{SD}	$I_{SD} = 6.5\text{A}$	-	-	1.25	V
		$I_{SD} = 2.0\text{A}$	-	-	1.10	V
Reverse Recovery Time	t_{rr}	$I_{SD} = 2.0\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	47	ns
Reverse Recovered Charge	Q_{RR}	$I_{SD} = 2.0\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	52	nC

Typical Performance Curves

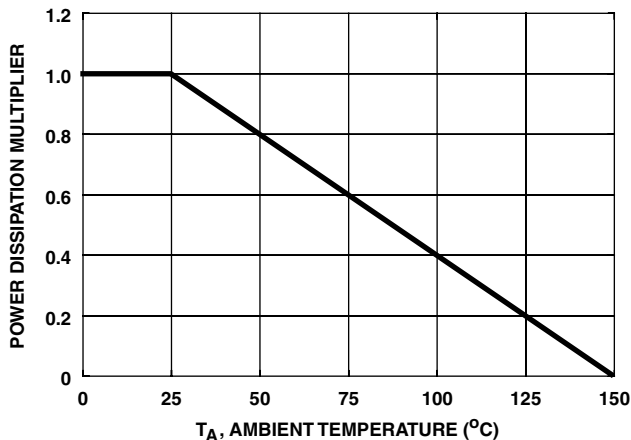


FIGURE 1. NORMALIZED POWER DISSIPATION vs AMBIENT TEMPERATURE

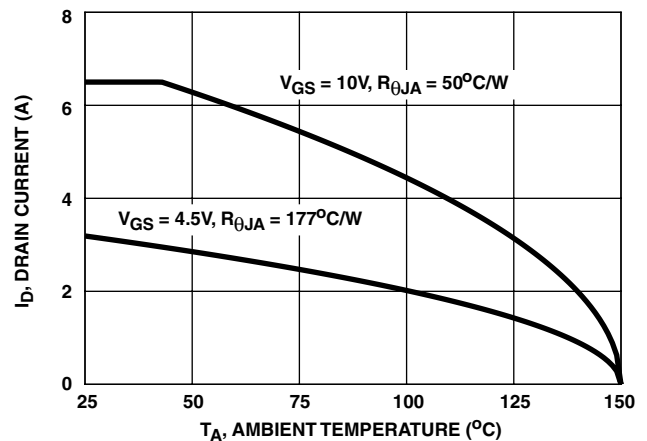


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs AMBIENT TEMPERATURE

Typical Performance Curves (Continued)

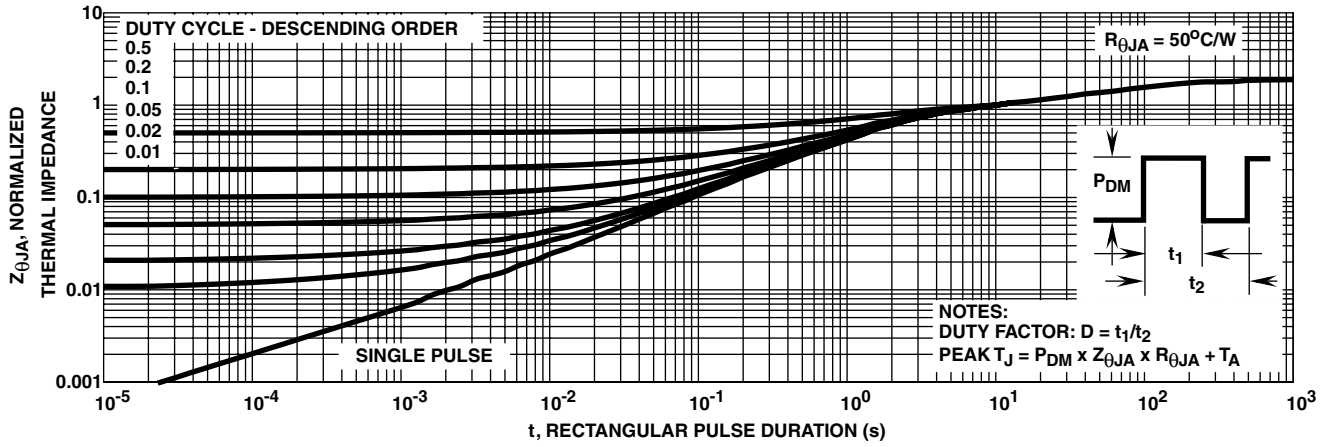


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

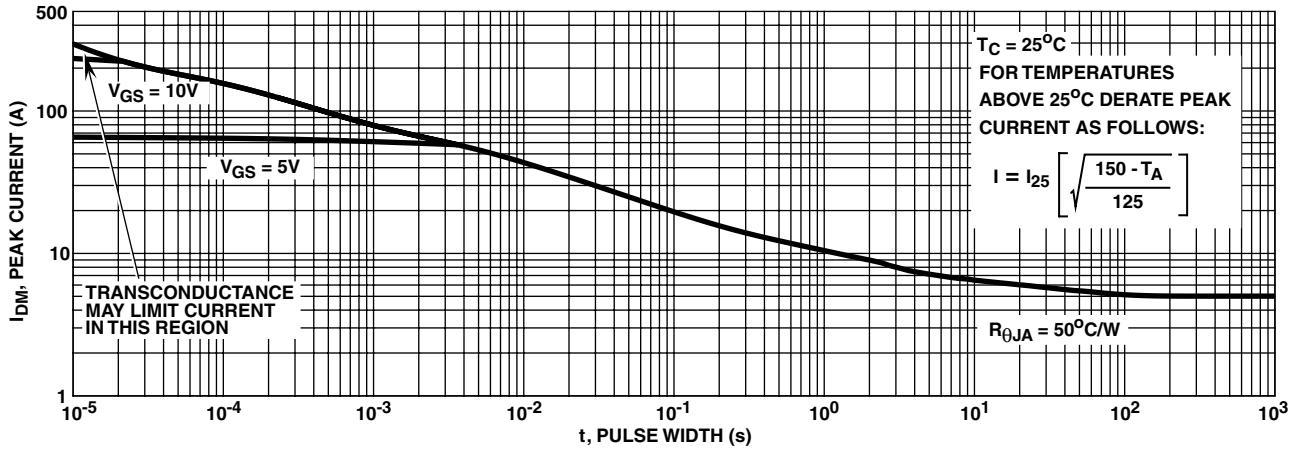


FIGURE 4. PEAK CURRENT CAPABILITY

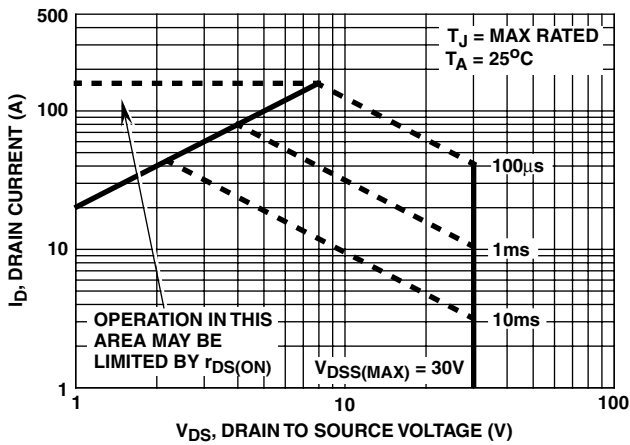
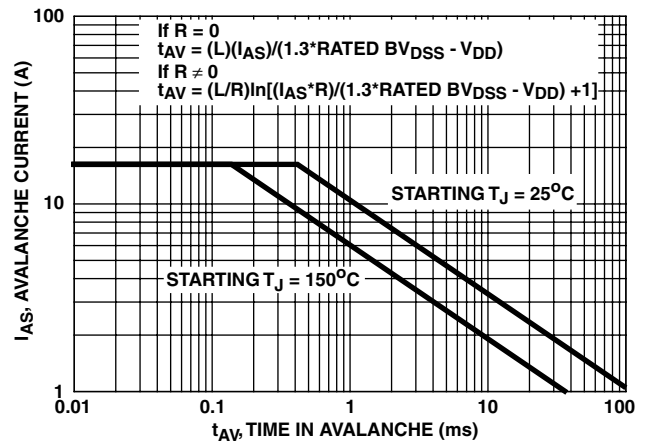


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA



NOTE: Refer to Fairchild Application Notes AN9321 and AN9322.

FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING CAPABILITY

Typical Performance Curves (Continued)

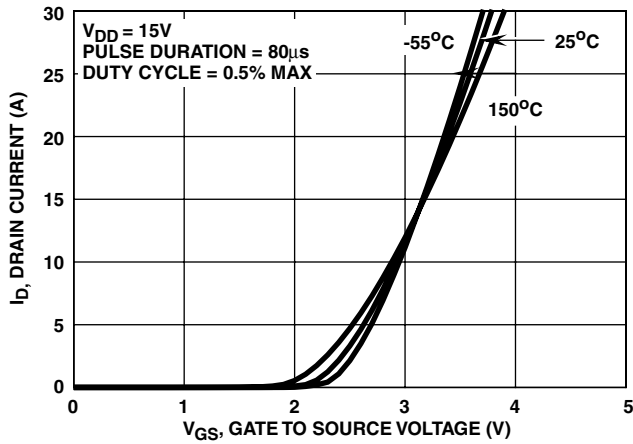


FIGURE 7. TRANSFER CHARACTERISTICS

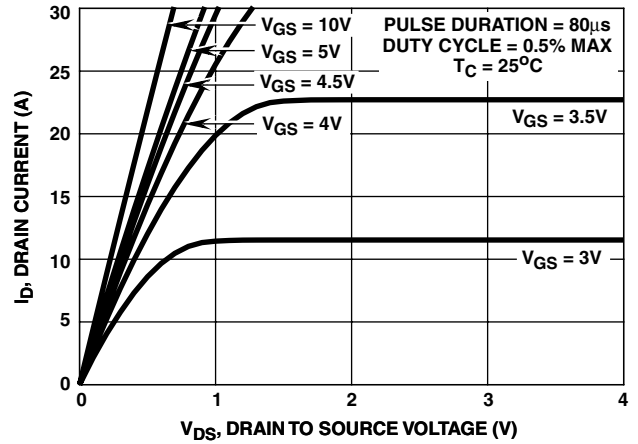


FIGURE 8. SATURATION CHARACTERISTICS

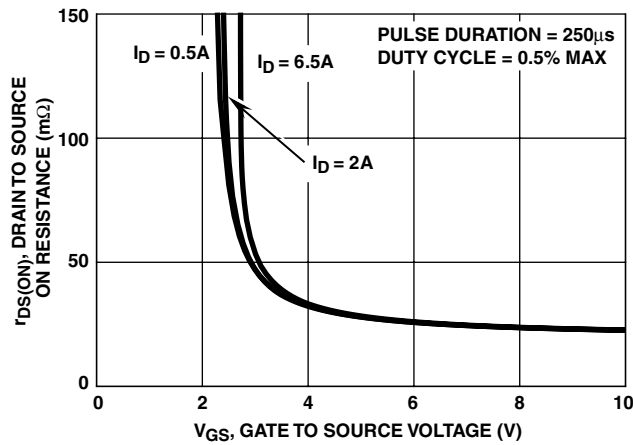


FIGURE 9. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

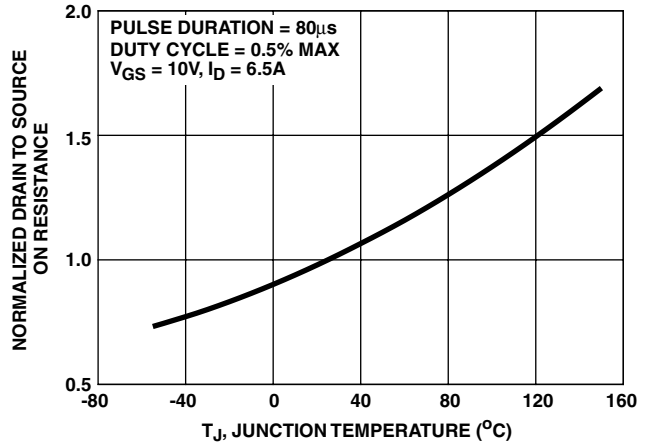


FIGURE 10. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

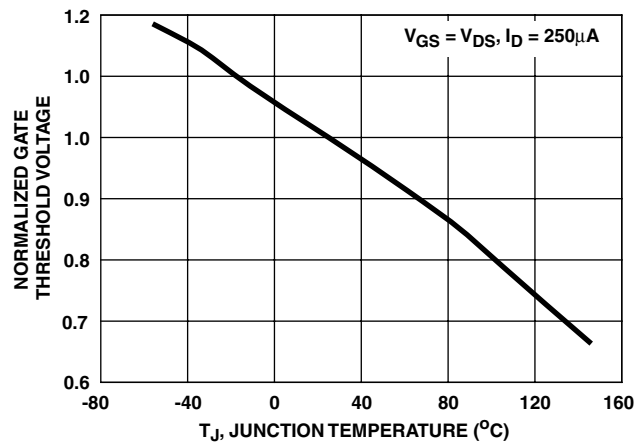


FIGURE 11. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

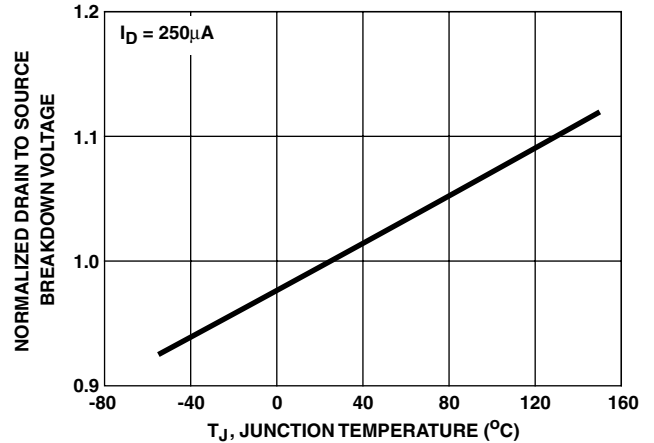


FIGURE 12. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

Typical Performance Curves (Continued)

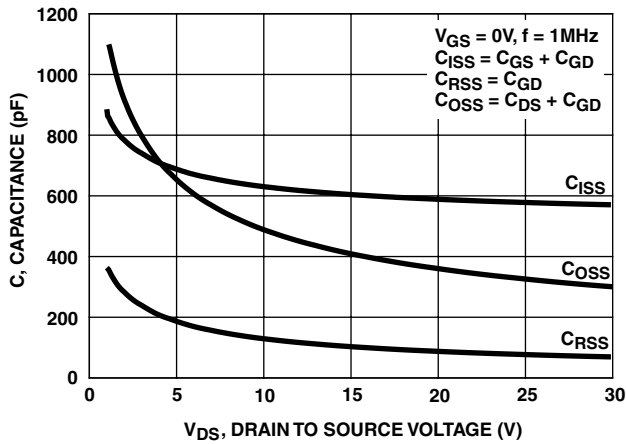
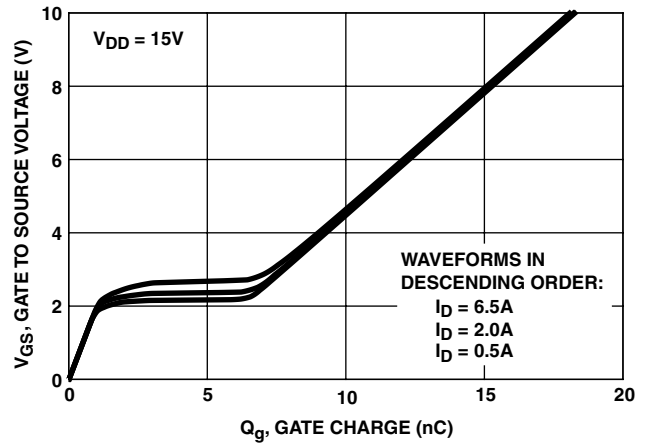


FIGURE 13. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Fairchild Application Notes AN7254 and AN7260.

FIGURE 14. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT

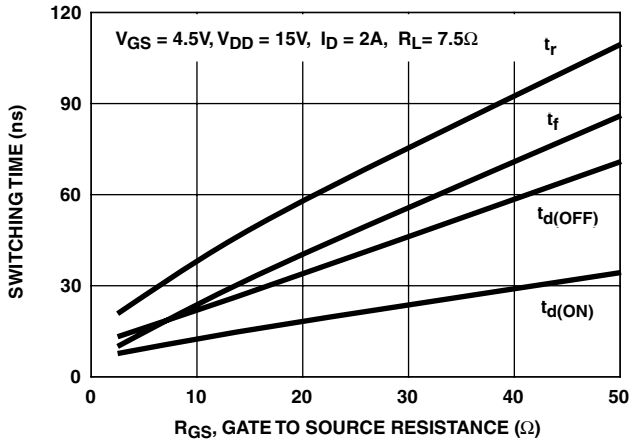


FIGURE 15. SWITCHING TIME vs GATE RESISTANCE

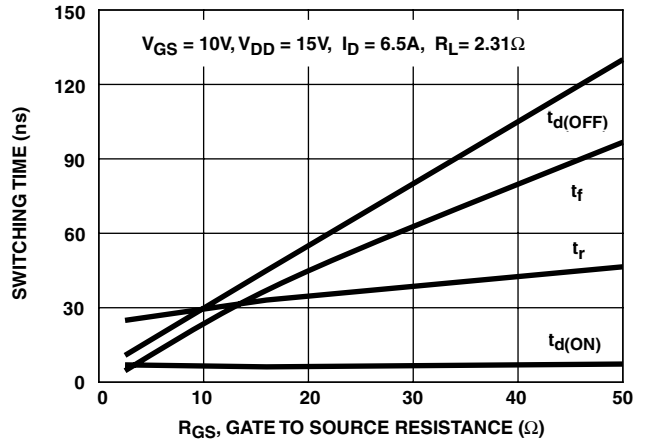


FIGURE 16. SWITCHING TIME vs GATE RESISTANCE

Test Circuits and Waveforms

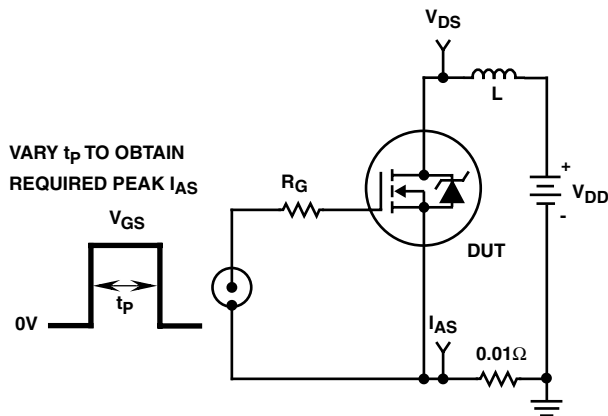


FIGURE 17. UNCLAMPED ENERGY TEST CIRCUIT

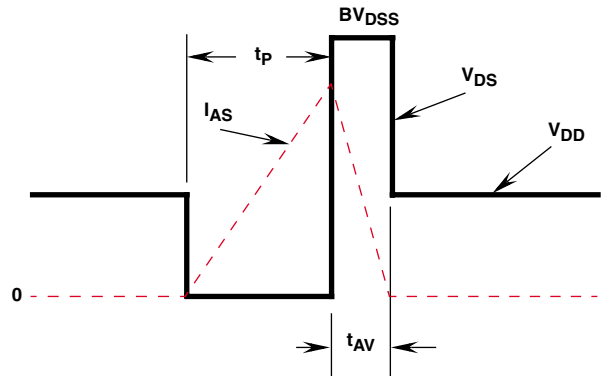


FIGURE 18. UNCLAMPED ENERGY WAVEFORM

Test Circuits and Waveforms (Continued)

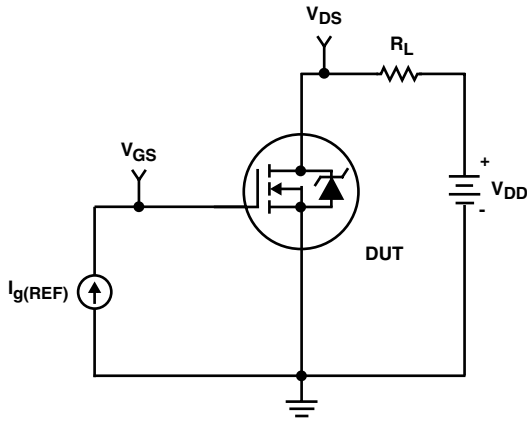


FIGURE 19. GATE CHARGE TEST CIRCUIT

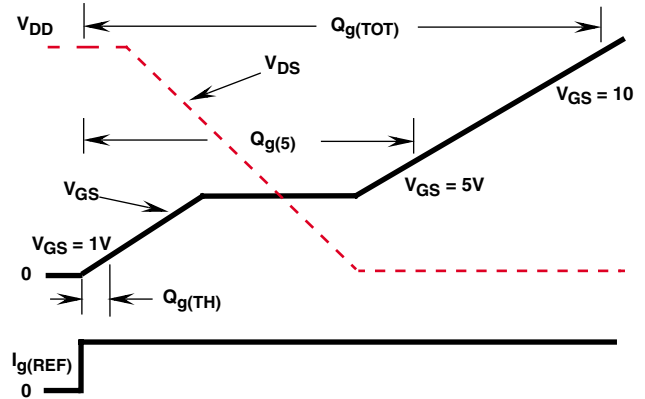


FIGURE 20. GATE CHARGE WAVEFORMS

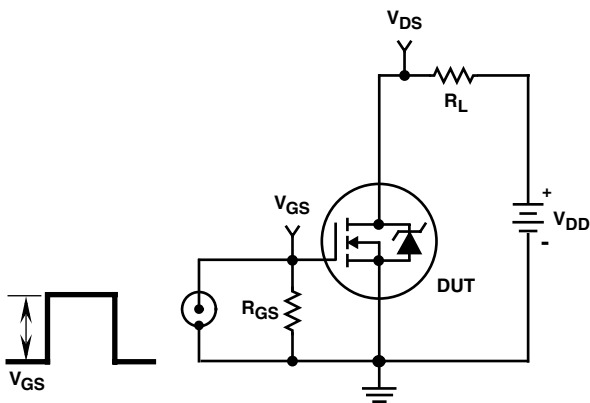


FIGURE 21. SWITCHING TIME TEST CIRCUIT

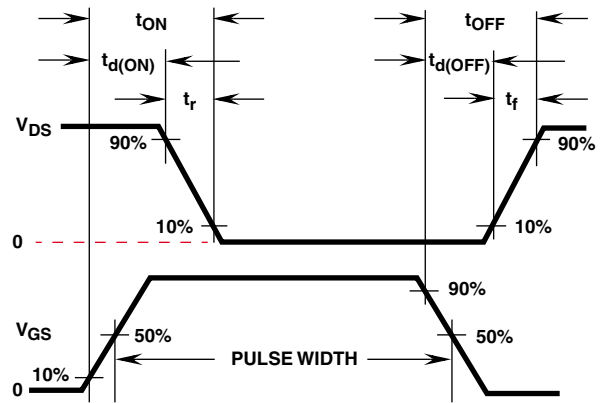


FIGURE 22. SWITCHING TIME WAVEFORMS

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, $T_{J(MAX)}$, and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, $P_{D(MAX)}$, in an application. Therefore the application's ambient temperature, T_A ($^{\circ}C$), and thermal resistance $R_{\theta JA}$ ($^{\circ}C/W$) must be reviewed to ensure that $T_{J(MAX)}$ is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DMAX} = \frac{(T_{JMAX} - T_A)}{Z_{\theta JA}} \quad (EQ. 1)$$

In using surface mount devices such as the SO-8 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of the $P_{D(MAX)}$ is complex and influenced by many factors:

1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board
2. The number of copper layers and the thickness of the board
3. The use of external heat sinks
4. The use of thermal vias
5. Air flow and board orientation
6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 23 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally

positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

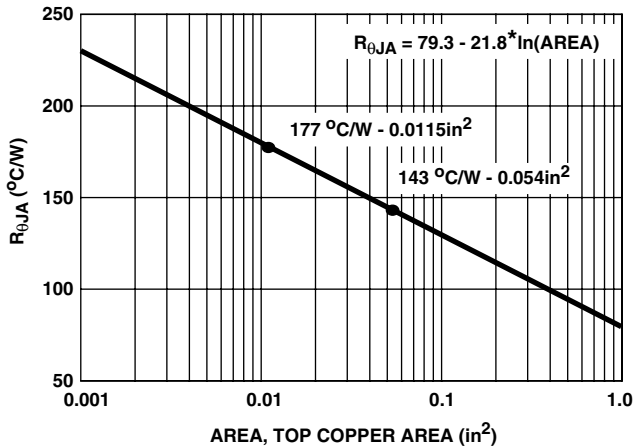


FIGURE 23. THERMAL RESISTANCE vs MOUNTING PAD AREA

Displayed on the curve are the three R_{θJA} values listed in the Electrical Specifications table. The three points were chosen to depict the compromise between the copper board area, the thermal resistance and ultimately the power dissipation, P_{D(MAX)}. Thermal resistances corresponding to other component side copper areas can be obtained from Figure 23 or by calculation using Equation 2. The area, in square inches is the top copper area including the gate and source pads.

$$R_{\theta JA} = 79.3 - 21.8 \times \ln(\text{Area}) \quad (\text{EQ. 2})$$

HUF76113SK8

PSPICE Electrical Model

SUBCKT HUF76113SK8 2 1 3 ; REV 4 June 1998

CA 12 8 9.60-10
 CB 15 14 9.95e-10
 CIN 6 8 5.01e-10

DBODY 7 5 DBODYMOD
 DBREAK 5 11 DBREAKMOD
 DPLCAP 10 5 DPLCAPMOD

EBREAK 11 7 17 18 32.3
 EDS 14 8 5 8 1
 EGS 13 8 6 8 1
 ESG 6 10 6 8 1
 EVTHRES 6 21 19 8 1
 EVTEMP 20 6 18 22 1

IT 8 17 1

LDRAIN 2 5 1.00e-9
 LGATE 1 9 1.00e-9
 LSOURCE 3 7 2.27e-10

MMED 16 6 8 8 MMEDMOD
 MSTRO 16 6 8 8 MSTROMOD
 MWEAK 16 21 8 8 MWEAKMOD

RBREAK 17 18 RBREAKMOD 1
 RDRAIN 50 16 RDRAINMOD 2.01e-3
 RGATE 9 20 2.94
 RLDRAIN 2 5 10
 RLGATE 1 9 10
 RLSOURCE 3 7 2.27
 RSLC1 5 51 RSLCMOD 1e-6
 RSLC2 5 50 1e3
 RSOURCE 8 7 RSOURCEMOD 17.50e-3
 RVTHRES 22 8 RVTHRESMOD 1
 RVTEMP 18 19 RVTEMPMOD 1

S1A 6 12 13 8 S1AMOD
 S1B 13 12 13 8 S1BMOD
 S2A 6 15 14 13 S2AMOD
 S2B 13 15 14 13 S2BMOD

VBAT 22 19 DC 1

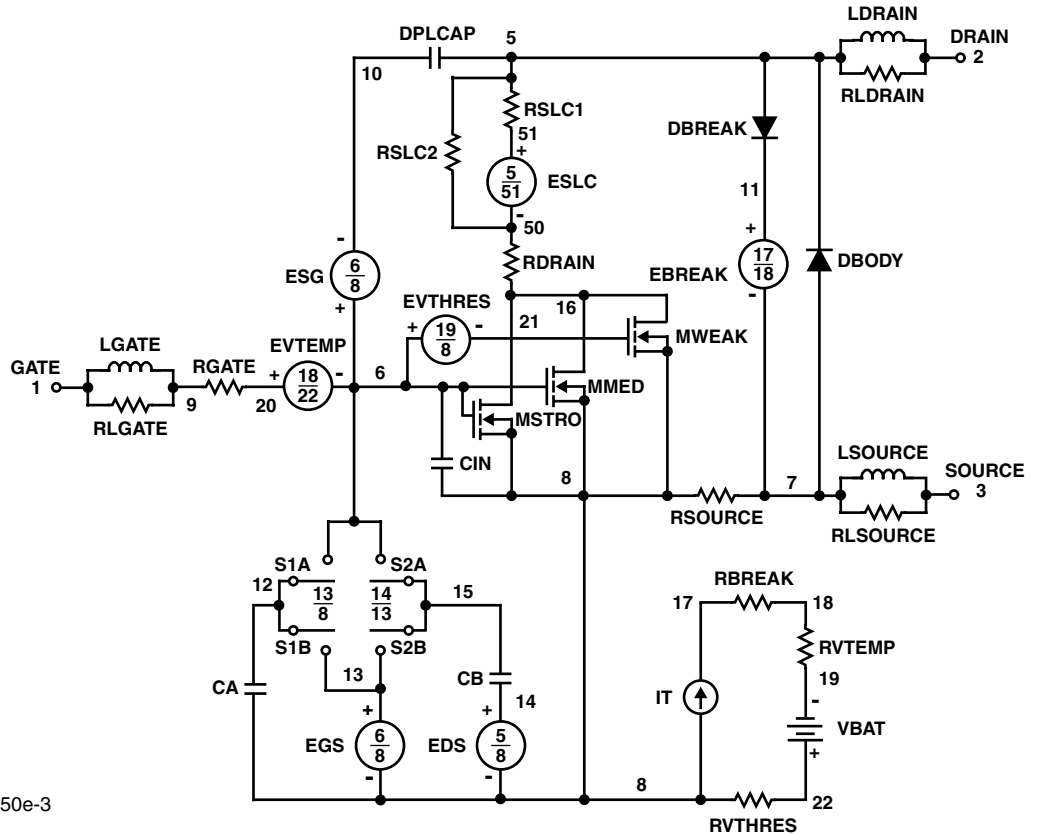
ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*180),2.5))}

.MODEL DBODYMOD D (IS = 9.35e-13 RS = 1.39e-2 TRS1 = 1.12e-6 TRS2 = 1.05e-6 CJO = 9.85e-10 TT = 2.82e-8 M = 0.42)
 .MODEL DBREAKMOD D (RS = 1.91e-1 TRS1 = 3.51e-3 TRS2 = 1.21e-6)
 .MODEL DPLCAPMOD D (CJO = 5.51e-10 IS = 1e-30 N = 10 M = 0.60)
 .MODEL MMEDMOD NMOS (VTO = 1.76 KP = 3.55 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 2.94)
 .MODEL MSTROMOD NMOS (VTO = 2.08 KP = 37 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
 .MODEL MWEAKMOD NMOS (VTO = 1.48 KP = 0.095 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 29.4 RS=0.1)
 .MODEL RBREAKMOD RES (TC1 = 1.02e-3 TC2 = 1.10e-7)
 .MODEL RDRAINMOD RES (TC1 = 4.05e-2 TC2 = 1.12e-4)
 .MODEL RSLCMOD RES (TC1 = 9.92e-3 TC2 = -2.06e-5)
 .MODEL RSOURCEMOD RES (TC1 = 0 TC2 = 0)
 .MODEL RVTHRESMOD RES (TC1 = -1.87e-3 TC2 = -5.42e-6)
 .MODEL RVTEMPMOD RES (TC1 = -1.12e-3 TC2 = 1.12e-6)

.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -7.00 VOFF= -1.55)
 .MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -1.55 VOFF= -7.00)
 .MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.00 VOFF= 1.05)
 .MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 1.05 VOFF= 0.00)

.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



SABER Electrical Model

nom temp=25 deg c HUF76113SK8 Ultrafet

REV 4 June 98

template huf76113sk8 n2,n1,n3
electrical n2,n1,n3

```
{
var i iscl
d..model dbodymod = (is=9.35e-13, cjo= 9.85e-10,tt=2.82e-8, m=0.42)
d..model dbreakmod = ()
d..model dplcapmod = (cjo=5.51e-10,is=1e-30,n=10,m=0.60)
m..model mmedmod = (type=_n,vto=1.76,kp=3.55,is=1e-30, tox=1)
m..model mstrongmod = (type=_n,vto=2.08,kp=37,is=1e-30, tox=1)
m..model mweakmod = (type=_n,vto=1.48,kp=0.095,is=1e-30, tox=1)
sw_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-7.00,voff=-1.55)
sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-1.55,voff=-7.00)
sw_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=0,voff=1.05)
sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=1.05,voff=0)
```

```
c.ca n12 n8 = 9.60e-10
c.cb n15 n14 = 9.95e-10
c.cin n6 n8 = 5.01e-10
```

```
d.dbody n7 n71 = model=dbodymod
d.dbreak n72 n11 = model=dbreakmod
d.dplcap n10 n5 = model=dplcapmod
```

```
i.it n8 n17 = 1
```

```
l.l drain n2 n5 = 1e-9
l.l gate n1 n9 = 1e-9
l.l source n3 n7 = 2.27e-10
```

```
m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u
```

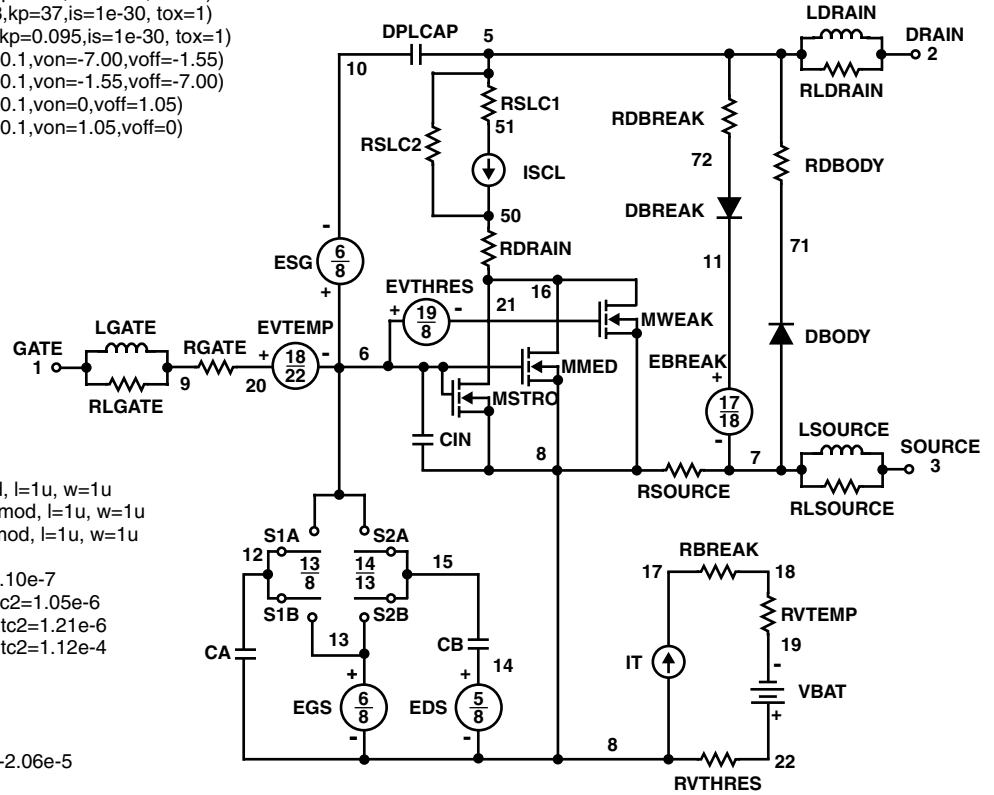
```
res.rbreak n17 n18 = 1, tc1=1.02e-3,tc2=1.10e-7
res.rbody n71 n5 = 1.39e-2, tc1=1.12e-6, tc2=1.05e-6
res.rdbreak n72 n5 = 1.91e-1, tc1=3.51e-3, tc2=1.21e-6
res.rdrain n50 n16 = 2.01e-3, tc1=4.05e-2,tc2=1.12e-4
res.rgate n9 n20 = 2.94
res.rldrain n2 n5 = 10
res.rlgate n1 n9 = 10
res.rlsource n3 n7 = 2.27
res.rslc1 n5 n51 = 1e-6, tc1=-9.92e-3,tc2=-2.06e-5
res.rslc2 n5 n50 = 1e3
res.rsource n8 n7 = 17.5e-3, tc1=0,tc2=0
res.rvtemp n18 n19 = 1, tc1=-1.12e-3,tc2=1.12e-6
res.rvthres n22 n8 = 1, tc1=-1.87e-3,tc2=-5.42e-6
```

```
spe.ebreak n11 n7 n17 n18 = 32.3
spe.eds n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1
spe.evthres n6 n21 n19 n8 = 1
```

```
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod
```

```
v.vbat n22 n19 = dc=1
```

```
equations {
i (n51->n50) +=iscl
iscl: v(n51,n50) = (((v(n5,n51))/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51))*1e6/180))** 2.5 ))
}
}
```



SPICE Thermal Model (0.76 in² footprint)

REV 3 June 1998

HUF76113SK8

CTHERM1 th 6 3.75e-4
 CTHERM2 6 5 3.05e-3
 CTHERM3 5 4 3.70e-2
 CTHERM4 4 3 2.52e-2
 CTHERM5 3 2 8.50e-2
 CTHERM6 2 tl 7.95e-1

RTHERM1 th 6 3.95e-2
 RTHERM2 6 5 2.50e-1
 RTHERM3 5 4 4.00e-1
 RTHERM4 4 3 6.35
 RTHERM5 3 2 2.02e1
 RTHERM6 2 tl 4.80e1

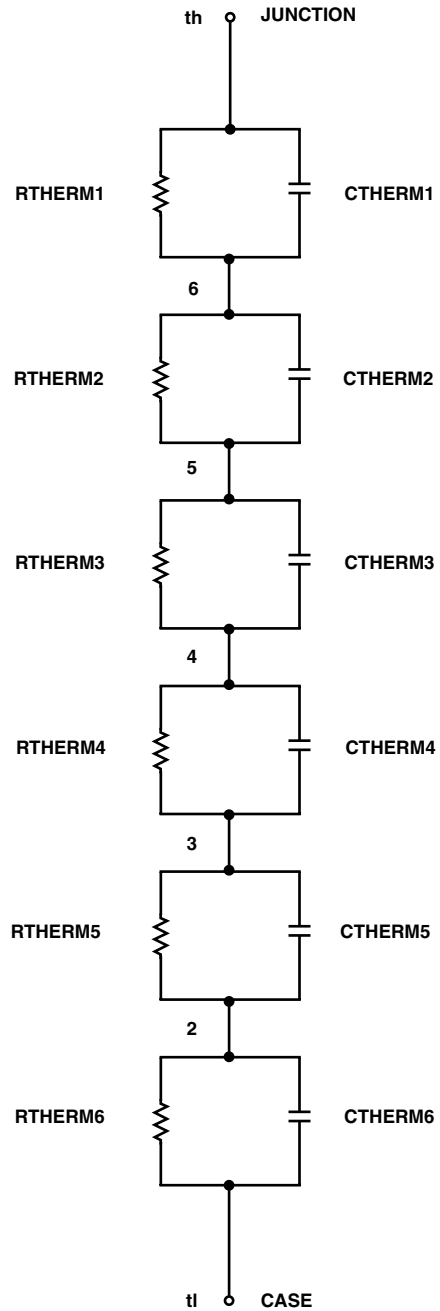
SABER Thermal Model (0.76 in² footprint)

SABER thermal model HUF76113SK8

```

template thermal_model th tl
thermal_c th, tl
{
    ctherm.ctherm1 th 6 = 3.75e-4
    ctherm.ctherm2 6 5 = 3.05e-3
    ctherm.ctherm3 5 4 = 3.70e-2
    ctherm.ctherm4 4 3 = 2.52e-2
    ctherm.ctherm5 3 2 = 8.50e-2
    ctherm.ctherm6 2 tl = 7.95e-1

    rtherm.rtherm1 th 6 = 3.95e-2
    rtherm.rtherm2 6 5 = 2.50e-1
    rtherm.rtherm3 5 4 = 4.00e-1
    rtherm.rtherm4 4 3 = 6.35
    rtherm.rtherm5 3 2 = 2.02e1
    rtherm.rtherm6 2 tl = 4.80e1
}
    
```



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